# Title

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Abstract—The abstract.

Index Terms—

#### I. Introduction

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# A. Subsection Heading Here

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#### II. RIPPLE CARRY ADDER

#### A. Adder Structures in FPGAs

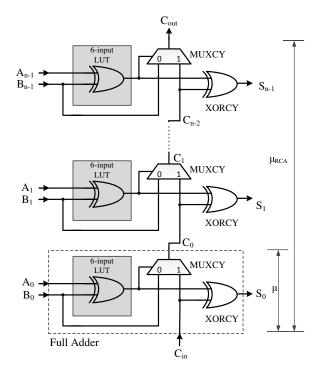
Adders serve as a key building block for arithmetic operations. Generally speaking, the ripple carry adder (RCA) is the most straightforward and widely used adder structure. As such, the philosophy of our approach is first exemplified with the analysis of a RCA. We later describe how this methodology can be extended to other arithmetic operators in Section III by discussing the CCM that is commonly used in DSP applications and numerical algorithms.

Typically the maximum frequency of a RCA is determined by the longest carry propagation. Consequently, modern FP-GAs offer built-in architectures for very fast ripple carry addition. For instance, the Altera Cyclone series uses fast tables [?] while the Xilinx Virtex series employs dedicated multiplexers and encoders for the fast carry logic [?]. Figure 1 illustrates the structure of an n-bit RCA, which is composed of n serial-connected full adders (FAs) and utilizes the internal fast carry logic of the Virtex-6 FPGA.

While the fast carry logic reduces the time of each individual carry-propagation delay, the overall delay of carry-propagation will eventually overwhelm the delay of sum generation of each LUT with increasing operand word-lengths. For our initial analysis, we assume that the carry propagation delay of each FA is a constant value  $\mu$ , which is a combination of logic delay and routing delay, and hence the critical path delay of the RCA is  $\mu_{RCA} = n\mu$ , as shown in Figure 1. For an n-bit RCA, it follows that if the sampling period  $T_S$  is greater than  $\mu_{RCA}$ , correct results will be sampled. If, however,  $T_S < \mu_{RCA}$ , intermediate results will be sampled, potentially generating errors.

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Fig. 1. An n-bit ripple carry adder in Virtex-6 FPGA.

In the following sections, we consider two methods that would allow the circuit to run at a frequency higher than  $1/T_S$ . The first is a traditional circuit design approach where operations occur without timing violations. To this end, the operand word-length is truncated in order to meet the timing requirement. This process results in truncation or roundoff error. In our proposed new scenario, circuits are implemented with greater word-length, but are clocked beyond the safe region so that timing violations sometimes occur. This process generates "overclocking error".

#### B. Probabilistic Model of Truncation Error

For ease of discussion, we assume that the input to our circuit is a fixed point number scaled to lie in the range [-1,1). For our initial analysis, we assume every bit of each input is uniformly and independently generated. However, this assumption will be relaxed in Section  $\ref{section}$  where the predictions are verified using real image data. The errors at the output are evaluated in terms of the absolute value and the probability of their occurring. These two metrics are combined as the error expectation.

If the input signal of a circuit is k bits, truncation error occurs when the input signal is truncated from k bits to n bits. Under this premise, the mean value of the truncated bits

at signal input  $(E_{Tin})$  is given by (1).

$$E_{Tin} = \frac{1}{2} \sum_{i=n+1}^{k} 2^{-i}$$

$$= 2^{-n-1} - 2^{-k-1}$$
(1)

Since we assume there are two mutually independent inputs to the RCA, the overall expectation of truncation error for the RCA is given by (2).

$$E_T = \begin{cases} 2^{-n} - 2^{-k}, & \text{if } n < k \\ 0, & \text{otherwise} \end{cases}$$
 (2)

# C. Probabilistic Model of Overclocking Error

1) Generation of Overclocking Error: For a given  $T_S$ , the maximum length of error-free carry propagation is described by (3), where  $f_S$  denotes the sampling frequency.

$$b := \left\lceil \frac{T_S}{\mu} \right\rceil = \left\lceil \frac{1}{\mu \cdot f_S} \right\rceil \tag{3}$$

However, since the length of an actual carry chain during execution is dependent upon input patterns, in general, the worst case may occur rarely. To determine when this timing constraint is not met and the size of the error in this case, we expand standard results [?] to the following statements, which examine carry generation, propagation and annihilation, as well as the corresponding summation results of a single bit i, according to the relationship between its input patterns  $A_i$  and  $B_i$ :

- If A<sub>i</sub> = B<sub>i</sub> = 1, a new carry chain is generated at bit i, and S<sub>i</sub> = C<sub>i-1</sub>;
- If  $A_i \neq B_i$ , the carry propagates for this carry chain at bit i, and  $S_i = 0$ ;
- If A<sub>i</sub> = B<sub>i</sub>, the current carry chain annihilates at bit i, and S<sub>i</sub>=1.

2) Absolute Value of Overclocking Error: For an n-bit RCA, let  $C_{tm}$  denote the carry chain generated at bit  $S_t$  with the length of m bits. For a certain  $f_S$ , the maximum length of error-free carry propagation, b, is determined through (3). The presence of overclocking error requires m > b. Since the length of carry chain cannot be greater than n, parameters t and t are bounded by (4) and (5):

$$0 \le t \le n - b \tag{4}$$

$$b < m \le n + 1 - t \tag{5}$$

For  $C_{tm}$ , correct results will be generated from bit  $S_t$  to bit  $S_{t+b-1}$ . Hence the absolute value of error seen at the output, normalized to the MSB  $(2^n)$ , is given by (6), where  $\hat{S}_i$  and  $S_i$  denote the actual and error-free output of bit i respectively.

$$e_{tm} = \frac{\left|\sum_{i=t+b}^{n} (S_i - \hat{S}_i) \cdot 2^i\right|}{2^n} \tag{6}$$

 $S_i$  and  $\hat{S}_i$  can be determined using the equations from the previous statements in Section II-C1. In the error-free case, the carry will propagate from bit  $S_t$  to bit  $S_{t+m-1}$ , and we will obtain  $S_{t+b} = S_{t+b+1} = \cdots = S_{t+m-2} = 0$  for carry propagation, and  $S_{t+m-1} = 1$  for carry annihilation.

However, when a timing violation occurs, the carry will not propagate through all these bits. Substituting these values into (6) yields (7). Interestingly, the value of overclocking error has no dependence on the length of carry chain m.

$$e_{tm} = \frac{\left| 2^{t+m-1} - 2^{t+m-2} - \dots - 2^{t+b} \right|}{2^n}$$

$$= 2^{t+b-n}$$
(7)

3) Probability of Overclocking Error: The carry chain  $C_{tm}$  occurs when there is a carry generated at bit t, a carry annihilated at bit t+m-1 and the carry propagates in between. Consequently, its probability  $P_{tm}$  is given by (8).

$$P_{tm} = P_{(A_t = B_t = 1)} P_{(A_{t+m-1} = B_{t+m-1})} \cdot \prod_{i=t+1}^{t+m-2} P_{(A_i \neq B_i)}$$
 (8)

Under the assumption that A and B are mutually independent and uniformly distributed, we have  $P_{(A_i=B_i=1)}=1/4$ ,  $P_{(A_i\neq B_i)}=1/2$  and  $P_{(A_i=B_i)}=1/2$ , so  $P_{tm}$  can be obtained by (9). Note that (9) takes into account the carry annihilation always occurs when t+m-1=n.

$$P_{tm} = \begin{cases} (1/2)^{m+1} & \text{if } t+m-1 < n\\ (1/2)^m & \text{if } t+m-1 = n \end{cases}$$
 (9)

4) Expectation of Overclocking Error: Expectation of overclocking error can be expressed by (10).

$$E_O = \sum_{t} \sum_{m} P_{tm} \cdot e_{tm} \tag{10}$$

Using  $P_{tm}$  and  $e_{tm}$  from (7) and (9) respectively,  $E_O$  can be obtained by (11).

$$E_O = \begin{cases} 2^{-b} - 2^{-n-1}, & \text{if } b \le n \\ 0, & \text{otherwise} \end{cases}$$
 (11)

#### D. Comparison between Two Scenarios

In the traditional scenario, the word-length of RCA must be truncated, using n = b - 1 bits, in order to meet a given  $f_S$ . The error expectation is then given by (12).

$$E_{trad} = 2^{-b+1} - 2^{-k} (12)$$

Overclocking errors are allowed to happen in the second scenario, therefore the word-length of RCA is set to be equal to the input word-length, that is, n = k. Hence we obtain (13) according to (11).

$$E_{new} = 2^{-b} - 2^{-k-1} (13)$$

Comparing (13) and (12), we have (14). This equation indicates that by allowing timing violations, the overall error expectation of RCA outputs drops by a factor of 2 in comparison to traditional scenario. This provides the first hint that our approach is useful in practice.

$$\frac{E_{new}}{E_{trad}} = \frac{2^{-b} - 2^{-k-1}}{2^{-b+1} - 2^{-k}} = \frac{1}{2}$$
 (14)

#### III. CONSTANT COEFFICIENT MULTIPLIER

As another key primitive of arithmetic operations, CCM can be implemented using RCA and shifters. For example, operation B=9A is equivalent to B=A+8A=A+(A<<3), which can be built using one RCA and one shifter. We first focus on a single RCA and single shifter structure. We describe how more complex structures consisting of multiple RCAs and multiple shifters can be built in accordance with this baseline structure in Section III-C.

In this CCM structure, let the two inputs of the RCA be denoted by  $A_S$  and  $A_O$  respectively, which are both two's complement numbers.  $A_S$  denotes the "shifted signal", with zeros padded after LSB, while  $A_O$  denotes the "original signal" with MSB sign extension. For an n-bit input signal, it should be noted that an n-bit RCA is sufficient for this operation, because no carry will be generated or propagated when adding with zeros, as shown in Figure 2.

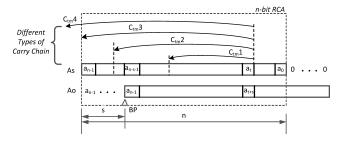


Fig. 2. Different types of carry chain in constant coefficient multiplier. The notion s denotes the shifted bits and BP denotes the binary point.

# A. Probabilistic Model of Truncation Error

Let  $E_{Tin}$  and  $E_{Tout}$  denote the expectation of truncation error at the input and output of CCM respectively. We then have (15), where coe denotes the coefficient value of the CCM, and  $E_{Tin}$  can be obtained according to (2).

$$E_{Tout} = |coe| \cdot E_{Tin} \tag{15}$$

#### B. Probabilistic Model of Overclocking Error

1) Absolute Value of Overclocking Error: The absolute value of overclocking error of carry chain  $C_{tm}$  is increased by a factor of  $2^s$  due to shifting, compared to RCA. Hence  $e_{tm}$  in CCM can be modified from (7) to give (16).

$$e_{tm} = 2^{t+b-n+s}$$
 (16)

- 2) Probability of Overclocking Error: Due to the dependencies in a CCM, carry generation requires  $a_t = a_{t-s} = 1$ , propagation and annihilation of a carry chain is best considered separately for four types of carry chain generated at bit t. We label these by  $C_{tm}1$  to  $C_{tm}4$  in Figure 2, defined by the end region of the carry chain. For  $C_{tm}1$ , we have:
  - Carry propagation:  $a_i \neq a_{i+s}$  where  $i \in [t+1, n-s-2]$ ;
- Carry annihilation:  $a_j = a_{j+s}$  where  $j \in [t+1, n-s-1]$ . Similarly for  $C_{tm}2$ , we have:
  - Carry propagation:  $a_i \neq a_{n-1}$  where  $i \in [n-s-1, n-3]$ ; or  $a_i \neq a_{i+s}$  where  $i \in [t+1, n-s-2]$ ;

• Carry annihilation:  $a_j = a_{n-1}$  where  $j \in [n-s-1, n-2]$ .

For the first two types of carry chain  $C_{tm}1$  and  $C_{tm}2$ , the probability of carry propagation and annihilation is 1/2 and the probability of carry generation is 1/4, under the premise that all bits of input signal are mutually independent. Therefore (17) can be obtained by substituting this into (8).

$$P_{tm} = (1/2)^{m+1}$$
, if  $t + m - 1 \le n - 2$  (17)

For carry annihilation of  $C_{tm}3$ ,  $a_{n-1}=a_{n-1}$ , which is always true. Thus the probability of  $C_{tm}3$  is given by (18).

$$P_{tm} = (1/2)^m$$
, if  $t + m - 1 = n - 1$  (18)

 $C_{tm}4$  represents carry chain annihilates over  $a_{n-1}$ , therefore carry propagation requires  $a_{n-1} \neq a_{n-1}$ . This means  $C_{tm}4$  never occurs in a CCM.

Altogether,  $P_{tm}$  for a CCM is given by (19).

$$P_{tm} = \begin{cases} (1/2)^{m+1} & \text{if } t+m-1 < n-1\\ (1/2)^m & \text{if } t+m-1 = n-1 \end{cases}$$
 (19)

3) Expectation of Overclocking Error: Since the carry chain of a CCM will not propagate over  $a_{n-1}$ , the upper bound of parameter t and m should be modified from (4) and (5) to give (20) and (21).

$$0 \leqslant t \leqslant n - b - 1 \tag{20}$$

$$b < m \leqslant n - t \tag{21}$$

Finally, by substituting (19) and (16) with modified bounds of t and m into (10), we obtain the expectation of overclocking error for a CCM to be given by (22).

$$E_O = \begin{cases} 2^{s-b-1} - 2^{s-n-1}, & \text{if } b \le n-1\\ 0, & \text{otherwise} \end{cases}$$
 (22)

# C. CCM with Multiple RCAs and Shifters

In the case where a CCM is composed of two shifters and one RCA, such as operation B = 20A = (A << 2) + (A << 4), let the shifted bits be denoted as  $s_1$  and  $s_2$  respectively. Hence the equivalent s in (22) can be obtained through (23).

$$s = |s_1 - s_2| \tag{23}$$

For those operations such as B=37A=(A<<5)+(A<<2)+(A<<1), the CCM can be built using a tree structure. Each root node is the baseline CCM and the errors are propagated through an adder tree, of which the error can be determined based on our previous RCA model.

# IV. CARRY SELECT ADDER

# A. Introduction

Since the delay of RCA is determined by the length of carry chain, the carry select adder (CSA) is designed to shorten the carry chain by overlapping carry propagation in sections such that the operating speed can be boosted. In a CSA, the carry chain is divided into multiple stages, as seen in Fig. xxx. Each stage contains two RCAs and two multiplexers. For a given input, two computations are performed simultaneously where the carry input is zero and one respectively. One of these two results is then selected according to the actual carry input.

Although this structure brings timing benefits, it costs extra hardware resources compared to a standard RCA because the carry chain is duplicated. Furthermore, in FPGA technology, multiplexers are expensive. Due to this reason, we explore the trade-offs between silicon area, accuracy and performance of these two adder structures in this section.

# B. Timing Models for Carry Select Adder

We initially model the CSA in order to understand the relationship between the operating frequency and the maximum word-length of the CSA. This information can then be employed to determine the truncation error based on the models presented in Section.xxx.

In a CSA with s stages ( $s \ge 2$ ), let the stage delay be denoted by  $d_{s-1}, \ldots, d_0$ , where  $d_{s-1}$  and  $d_0$  represent the delay of the most significant and the least significant stages, respectively. In our analysis, we follow the assumption that the critical path delay is due to carry propagation and multiplexing the carry output. Note that unlike other stages, the least significant stage is only built by one RCA without multiplexers, since it is directly driven by the carry input. Hence we obtain the delay of the  $i^{th}$  stage as presented in (24), where  $\mu_c$ ,  $\mu_{mux}$  and  $n_i$  denote the delay of 1-bit carry propagation, the delay of multiplexing and the word-length of the  $i^{th}$  stage of the CSA, respectively.

$$d_{i} = \begin{cases} n_{i} \cdot \mu_{c} + (s - i) \cdot \mu_{mux}, & \text{if } i \in [1, s - 1] \\ n_{0} \cdot \mu_{c} + (s - 1) \cdot \mu_{mux}, & \text{if } i = 0 \end{cases}$$
 (24)

Under the timing-driven design environment, the delay of each stage of CSA is equalized in order to achieve the fastest operation, as presented in (25).

$$d_{s-1} = d_{s-2} = \dots = d_0 \tag{25}$$

In this case, combining (24) and (25) yields  $n_i$ , which is represented by the word-length of the most significant stage  $n_{s-1}$ , in (26).

$$n_i = \begin{cases} n_{s-1} - (s-1-i) \cdot \frac{\mu_{mux}}{\mu_c}, & \text{if } i \in [1, s-1] \\ n_{s-1} - (s-2) \cdot \frac{\mu_{mux}}{\mu_c}, & \text{if } i = 0 \end{cases}$$
 (26)

Summing up  $n_i$  gives the total word-length of the CSA in (27).

$$n_{CSA} = \sum_{i=0}^{s-1} n_i$$

$$= s \cdot n_{s-1} - \frac{\mu_{mux}}{\mu_c} \cdot \frac{(s+1)(s-2)}{2}$$
(27)

Conventionally a given frequency constraint is met by selecting word-lengths of each stage of the CSA in order to satisfy (28).

$$d_i \leqslant \frac{1}{f_s}$$
 ,  $\forall i \in [0, s-1]$  (28)

Under this situation, the maximum word-length of the most significant stage  $n_{s-1}$  is given by (29), where b is determined by (3).

$$n_{s-1} \cdot \mu_c + \mu_{mux} = b \cdot \mu_c \tag{29}$$

Substitute (29) into (27), we derive the representation of the word-length of CSA in terms of a given timing constraint, as presented in (30).

$$n_{CSA} = s \cdot b - \frac{\mu_{mux}}{\mu_c} \cdot \frac{(s+2)(s-1)}{2}$$
 (30)

# C. Model Verification

The ratio  $\mu_{mux}/\mu_c$  can be computed from experiments. We perform post place-and-route simulations on the CSA with 2 stages using Xilinx Virtex-6 FPGA. The delay of the  $i^{th}$  stage  $d_i$  in (24) is recorded with respect to different word-lengths of this given stage  $(n_i)$ . Then the total word-length of CSA can be predicted through (30). In addition, the maximum word-length of the 2-stage CSA is obtained experimentally by increasing  $n_{CSA}$  until errors are observed at the output. The comparison between the modeled value and the empirical results of  $n_{CSA}$  is illustrated in Fig. (3). It can be seen that our model match well with the experimental results.

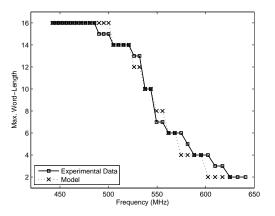
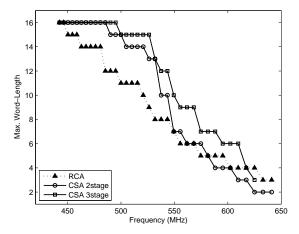


Fig. 3. Comparison of the maximum word-length between the modeled value and the experimental results from FPGA simulations.

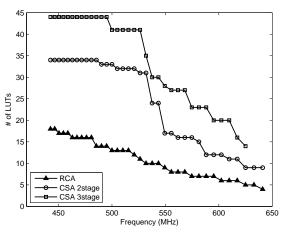
# D. Accuracy Benefits and Area Overhead in CSA

As greater word-length corresponds to smaller truncation errors, we compare the maximum word-length of RCA and CSA with 2 stages and 3 stages over a range of operating frequencies, as presented in Fig. 4(a). It can be seen from Fig. 4(a) that in comparison to RCA, CSA achieves greater word-length when frequency is initially increased. RCA only outperforms than CSA when very high frequency is applied. This is because at low frequencies, although the multiplexer delay limits the word-length of each stage in CSA when compared to RCA, the stage parallelism in CSA enables a greater word-length. However when frequency increases, the multiplexer delay becomes comparable to the delay of the carry chain, and this inhibits the benefits of parallelism. In addition, we can see that the word-length of 3-stage CSA is always greater than 2-stage CSA across the entire frequency

However, the accuracy benefits brought by CSA comes at the cost of a large area overhead. Fig. 4(b) depicts the number of Look-Up Tables (LUTs) in the FPGA used for



(a) Maximum word-length.



(b) Hardware resource usage.

Fig. 4. Comparison between RCA and CSA across a variety of frequency values in terms of the maximum word-length of input signal and the area consumption.

all three structures. It can be seen that in order to meet a given frequency, the 3-stage CSA consumes  $2.4\times \sim 3.7\times$  area than RCA, while a 2-stage CSA requires  $1.7\times \sim 3.1\times$  extra area. This finding poses a question of which is the best adder structure for a given area budget.

# E. Exploring Trade-offs Between Accuracy, Performance and Area

In the conventional design scenario, the word-length of the RCA and CSA are limited by the following two factors:

- The critical path of the adder;
- The available silicon area.

We compare the accuracy, performance and area trade-offs to an RCA where the maximum possible word-length is limited by the given area budget, and the timing constraints are allowed to be violated.

Suppose an algorithm designer would wish to create a circuit that can run at a given frequency with the minimum achievable output errors and resource usage. In this case, for

a certain pair of  $\{Area, Frequency\}$  constraint, the optimum design method is selected based on the following criteria:

- Design with the best accuracy at outputs is the optimum design;
- If multiple designs achieve the same accuracy, then the design with minimum area is the optimum design;
- If the accuracy and area are identical for multiple designs, they are all treated as the optimum design.

If we define the accuracy in terms of the error expectation at the output. The optimum design method with respect to a variety of operating frequencies and area consumptions is demonstrated in Fig. 5. From this figure several observations can be made. If the available area is large enough to implement a CSA in full precision, it will be the optimum design. This is expected from our earlier analysis in Fig (4(a)). The 2stage CSA is better than the 3-stage CSA when frequency is initially increased, as it consumes less area although both of them achieve the same error expectation. For a tighter area budget, only part of the CSA can be implemented, whereas the RCA still keeps full precision. In this case, area becomes the dominate factor and precision is lost for the CSA. In this case we see the RCA with overclocking is the optimum design method across almost the whole frequency domain. For more stringent area constraints, the word-length of RCA is also limited. This results in truncation error initially for all design scenarios. However, the RCA with overclocking is still ......

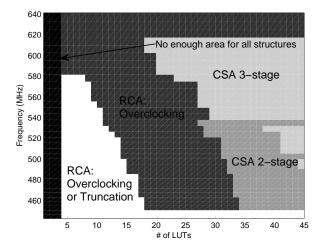


Fig. 5. Demonstration of the optimum design methodology which achieves the minimum error at outputs with respect to a variety of frequency and area constraints.

Similarly if the algorithm designer would expect the circuit to operate as fast as possible with the minimum area whilst a certain error budget can be tolerated, the optimum design methodology can be decided as illustrated in Fig. (6). In this situation, the error specifications are evaluated in terms of mean relative error (MRE), as presented in (31), where  $E_{error}$  and  $E_{out}$  refer to the mean value of error and the mean value of outputs, respectively.

$$MRE = \left| \frac{E_{error}}{E_{out}} \right| \times 100\% \tag{31}$$

In our experiments, MRE is set ranging from 0.001% to 50%. For a certain MRE, the design with the maximum operating frequencies is labeled as the optimum design. Moreover, the smallest design is the optimum one if multiple structures operate at the same frequency, with a certain area. Based on these criteria, the decision graph is depicted in Fig. (6).



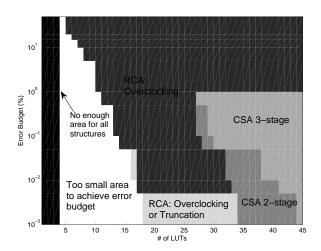


Fig. 6. Demonstration of the optimum design methodology which runs at the fastest frequency with respect to a variety of accuracy and area constraints.

For a tight accuracy requirement, i.e. MRE < 0.005%, CSA serves as the optimum design choice with respect to large accessible area, as it intrinsically operates faster than RCA. Once again, when the area budget shrinks, the RCA performs best because the precision of the CSA is limited. Similarly to the previous section, we see that the overclocked RCA achieves the fastest operating frequencies with respect to most area constraints.

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#### V. CONCLUSION

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#### ACKNOWLEDGMENT

The authors would like to thank...

#### REFERENCES

 H. Kopka and P. W. Daly, A Guide to ETEX, 3rd ed. Harlow, England: Addison-Wesley, 1999.

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